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Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/774,099	ONISHI ET AL.	
Examiner	Art Unit	
Srilokshmi K Kumar	2620	

	SEARCHED				
Class	Subclass	Date	Examiner		
345	211-213, 99	12/14/2003	ADN		
Update	Search	1/26/2006	ADN		
Update	Search	11/7/2006	SKK		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See Interference Search		11/8/2006	SKK	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
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